

Notice of References Cited

Application/Control No.

10/582,053

Applicant(s)/Patent Under
Reexamination
KEUL ET AL.

Examiner

Liam J. Heincer

Art Unit

1796

Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,652,667 A	03-1987	Green, Michael J.	558/277
*	B	US-4,713,188 A	12-1987	Wollenberg, Robert H.	508/222
*	C	US-4,720,569 A	01-1988	Tominaga, Akira	560/26
*	D	US-5,047,261 A	09-1991	Moussa et al.	427/508
*	E	US-5,245,032 A	09-1993	King, Stephen W.	544/162
*	F	US-5,637,655 A	06-1997	Priddy et al.	525/438
*	G	US-5,874,509 A	02-1999	Shalaby et al.	526/194
*	H	US-6,090,891 A	07-2000	Frischinger et al.	525/111
*	I	US-6,084,038 A	07-2000	Ohrbom et al.	525/481
*	J	US-6,162,769 A	12-2000	Polhaar et al.	508/339
*	K	US-6,177,514 B1	01-2001	Pathak et al.	525/54.1
*	L	US-2002/0006558 A1	01-2002	Kobayashi et al.	430/7
*	M	US-2002/0038041 A1	03-2002	Clements et al.	549/525

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/582,053	Applicant(s)/Patent Under Reexamination KEUL ET AL.	
	Examiner Liam J. Heincer	Art Unit 1796	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0040110 A1	04-2002	Webster et al.	525/400
*	B	US-6,407,199 B1	06-2002	Hirata et al.	528/196
*	C	US-6,447,952 B1	09-2002	Spiegel et al.	429/218.1
*	D	US-2003/0097961 A1	05-2003	Yatake et al.	106/31.59
*	E	US-2003/0139556 A1	07-2003	Wagener et al.	527/201
*	F	US-2003/0134926 A1	07-2003	Fukada et al.	522/81
*	G	US-2003/0193042 A1	10-2003	Go et al.	252/500
*	H	US-2003/0186013 A1	10-2003	Dhaler et al.	428/40.1
*	I	US-2004/0091426 A1	05-2004	Schmitt-Willich et al.	424/009.322
*	J	US-2004/0127608 A1	07-2004	Pardoen et al.	524/088
*	K	US-6,824,848 B2	11-2004	Dhaler et al.	428/40.1
*	L	US-2004/0236119 A1	11-2004	Van Hohen, Jurgen	549/229
*	M	US-6,849,665 B2	02-2005	Frenz et al.	521/64

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/582,053	Applicant(s)/Patent Under Reexamination KEUL ET AL.	
	Examiner Liam J. Heincer	Art Unit 1796	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,887,946 B2	05-2005	Fukada et al.	525/437
*	B	US-2005/0118105 A1	06-2005	Platzek et al.	424/009.322
*	C	US-6,998,078 B2	02-2006	Wierer et al.	264/83
*	D	US-2006/0029782 A1	02-2006	Harren et al.	428/212
*	E	US-2007/0066754 A1	03-2007	Loeker et al.	525/127
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.